Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/709,759	LIAW ET AL.	
Examiner	Art Unit	
Dustin Nguyen	2154	

	SEAR	CHED	
Class	Subclass	Date	Examiner
700	19	1/20/2006	DN
709	219	1/20/2006	DN
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INTERFERENCE SEARCHED			
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SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
search EAST, copending case 10667132	1/20/2006	DN